

# ELEN0040 - Electronique numérique

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# CHAPITRE 7

## Memory basics

## ① Memory definitions

- 1.1 Essential characteristics
- 1.2 Access types
- 1.3 Register file
- 1.4 RAM and ROM memories

## ② Random Access Memory (RAM)

- 2.1 Two families
- 2.2 Static RAM
  - Operation timing
  - SRAM Cell
  - SRAM Chip realization
  - Association of SRAM Chips
- 2.3 Dynamic RAM
  - DRAM Cell
  - DRAM Bit Slice
  - Refresh logic and DRAM operation timing
  - DRAM types

## ③ Read Only Memory (ROM)

- 3.1 Internal structure
- 3.2 Different types

# Definitions

## Memory

An electronic device capable of **storing** binary information and which allows the stored data **to be accessed** and **retrieved**.

- ▶ A memory is made of a collection of storage cells called **memory cells** together with the necessary circuits to transfer information to and from them.
- ▶ Memories are classified according to their
  - ▶ **characteristics** : capacity, volatility, ...
  - ▶ **access type** : direct (or random) vs. sequential

# Essential characteristics

- ▶ Data elements :
  - ▶ **bit** : a single binary digit, the smallest data element (relative to one memory cell)
  - ▶ **byte** : a group of eight bits
  - ▶ **word** : a group of bytes whose size is a typical unit of access for the memory; the memory is organized as an array of words of  $n$  bits. A word is the entity of bits that moves out and in of memory
- ▶ **Capacity** : the amount of information that can be stored in the memory, it is expressed as a number of words :  $m$  words  $\times n$  bits, example :  $64K \times 8$ bits.
- ▶ Each word is identified by its **address**, a binary identification number of each word of the memory. For a capacity of  $m$  words,  $k = \lceil \log_2 m \rceil$  address bits are required.  
The capacity is usually expressed in terms of :  
 $K = 2^{10}$  ,  $M = 2^{20}$  ,  $G = 2^{30}$

# Essential characteristics (continued)

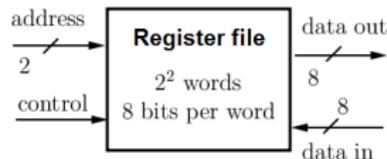
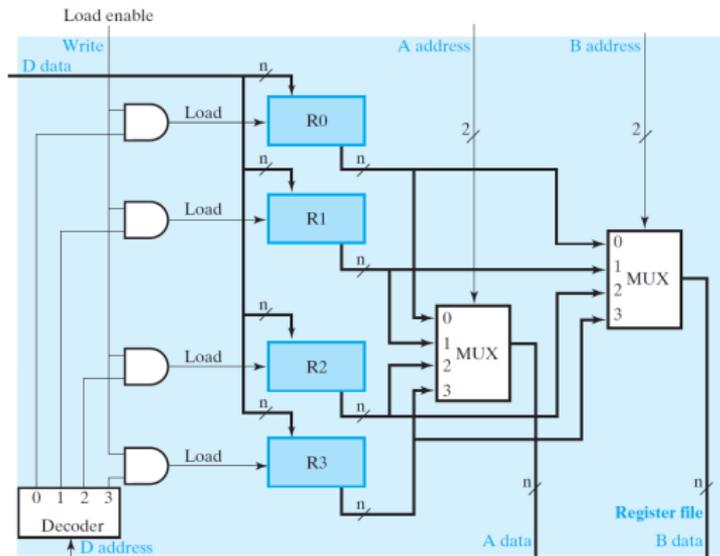
- ▶ **Volatility** :
  - ▶ if the information stored in memory is lost when power is turned off, the memory is said to be **volatile**. It needs external power to maintain the stored information.
  - ▶ Otherwise, it is said to be **nonvolatile** and the information is kept in memory after power is turned off.
- ▶ Two basic memory operations :
  - ▶ **read** the values of the data stored in one word of the memory. The data in memory is transferred to processing parts of the system
  - ▶ **write** data values in a word of memory. The data are transferred and kept in memory
- ▶ **Access time** : the time interval between the request of a read operation and the time when the read data are made available
- ▶ **Cycle time** : the minimum time interval between two successive memory accesses

# Access types

- ▶ **Direct** access, also called “random” access :
  - ▶ each word of information has **its own address**
  - ▶ each address can be **directly** accessed
  - ▶ the access time is **independent** of the information location
  - ▶ example : computer central memory
- ▶ **Sequential** access :
  - ▶ the access takes **different times** depending on the information location
  - ▶ example : hard drive where access time depends on where the desired location is relative to the current physical position
  - ▶ much slower than direct access

# Register file

- ▶ We already know a type of memory : **registers**
- ▶ Registers are included in the datapath of digital systems
- ▶ We call **Register File** the part of the datapath including the registers and their associated selection circuitry
- ▶ Example, a register file with 4 8-bit registers =  $4 \times 8$  memory, 4 words and 8 bits



## Characteristics :

- ▶ volatile
- ▶ sequential synchronous system
- ▶ direct access
- ▶ memory cell = one flip-flop
- ▶ Access and cycle time = one clock cycle
- ▶ **very fast** but **biggest size** (flip-flop)

# RAM and ROM memories

Memories with higher capacity are required.

- ▶ **RAM or Random Access Memory** (“mémoire vive”) :
  - ▶ volatile memory : data are lost at power off
  - ▶ read and write operations
  - ▶ direct access
  - ▶ sequential system
  - ▶ requires :  $n$  data input and output lines,  $k$  address lines, read/write controls
- ▶ **ROM or Read Only Memory** (“mémoire morte”) :
  - ▶ non volatile memory : information is “programmed”, stored permanently and cannot be changed in normal operation
  - ▶ no write operation in normal operation
  - ▶ direct access
  - ▶ combinational system
  - ▶ requires :  $n$  data output lines,  $k$  address lines

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- 1.4 RAM and ROM memories

## ② Random Access Memory (RAM)

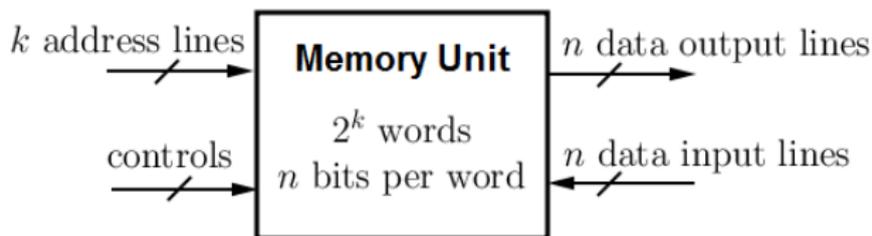
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- 2.2 Static RAM
  - Operation timing
  - SRAM Cell
  - SRAM Chip realization
  - Association of SRAM Chips
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## ③ Read Only Memory (ROM)

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# Random Access Memory

- ▶ logically similar to register file
- ▶ stores bits using a bit storage approach that is more efficient (in terms of size) than a flip-flop
- ▶  $k$  address lines are decoded to address  $2^k$  words of memory
- ▶ each word is  $n$  bits
- ▶ the control signals are used to define the memory operation (read, write, no operation or more elaborate operation)
- ▶ read values are put on the  $n$  output data lines
- ▶ values to be written in memory are put on the  $n$  input data lines, which can coincide to the output lines in case of bidirectional bus



# RAM memories : two technology families

## ▶ SRAM or Static RAM :

- ▶ the binary information is stored by latches
- ▶ the stored information is valid as long as supply power is applied
- ▶ **static** behavior

## ▶ DRAM or Dynamic RAM

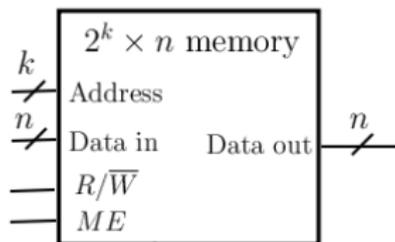
- ▶ the binary information is stored in the form of electrical charges on a capacitor
- ▶ the capacitor tends to discharge with time, **dynamic** behavior
- ▶ the capacitor has to be **periodically recharged**
- ▶ the DRAM cell is **refreshed** every few ms, reading and rewriting the information stored

## ▶ Comparison :

	SRAM	DRAM
Cost	high	moderate
Speed	high	slower
Refresh	No	Yes
Power consumption	high	low

# Read and write operations

Consider a  $2^k \times n$  memory. Its behavior is determined by the two control signals  $ME$  and  $R/\overline{W}$ .

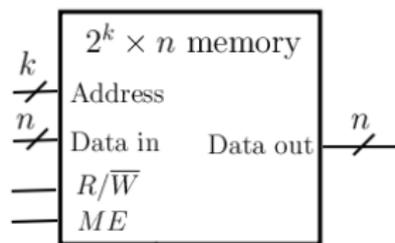


$ME = 0$		No operation
$ME = 1$	$R/\overline{W} = 1$	Read
$ME = 1$	$R/\overline{W} = 0$	Write

- ▶  $ME$  is the memory enable control, it enables or disables the RAM
- ▶ Address specifies the location to read from or write to
- ▶  $R/\overline{W}$  selects between reading or writing
  - ▶ to read,  $R/\overline{W} = 1$  and Data out will be the  $n$ -bit value stored at Address
  - ▶ to write,  $R/\overline{W} = 0$  and Data is is the  $n$ -bit value to save at Address

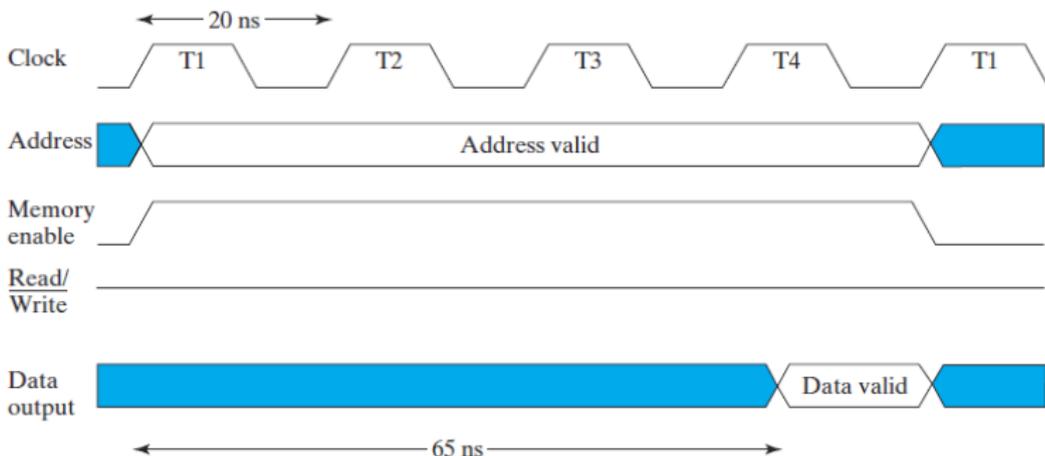
## Read and write operations

- ▶ To **read** from this RAM, the controlling circuit must :
  - ▶ enables the operation by setting  $ME = 1$
  - ▶ select the read operation by setting  $R/\overline{W} = 1$
  - ▶ place a valid address on the Address input
  - ▶ the contents of the memory at Address appear on data out at the end of the access time, after transients have died out and signals stabilized
  - ▶ The input Data in is not used for read operation
- ▶ To **write** to this RAM, the controlling circuit must :
  - ▶ enables the operation by setting  $ME = 1$
  - ▶ select the write operation by setting  $R/\overline{W} = 0$
  - ▶ place the desired address to the Address input
  - ▶ place the word to be stored on the Data input
  - ▶ The output Data out is not used for write operation



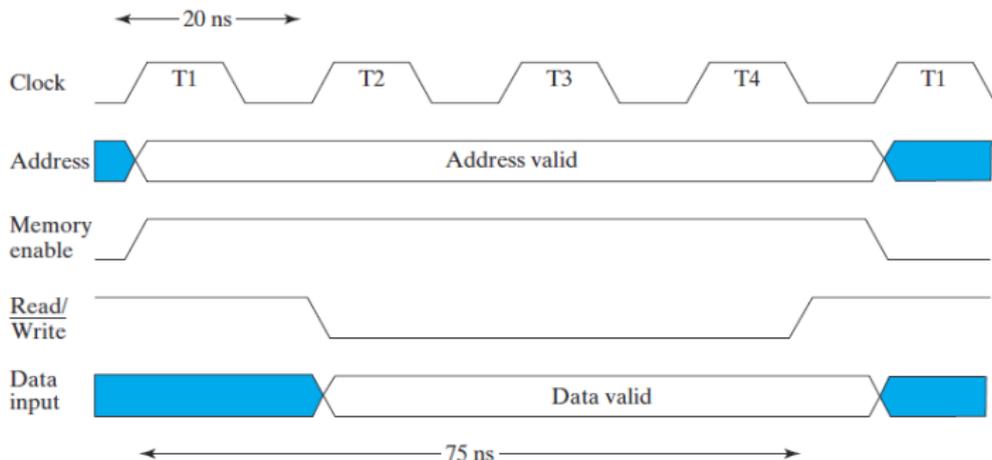
## Memory operation timing

- ▶ Most basic memory are asynchronous
- ▶ Read and write operations are timed by changes in values on the control signals  $ME$  and  $R/\overline{W}$ . Example of **read timing** :
  - ▶ CPU clock period = 20 ns, access time = 65 ns, cycle time = 75 ns
  - ▶ 4 clock pulses are required for one memory request
  - ▶ the address is applied with  $ME$  set to 1,  $R/\overline{W} = 1$
  - ▶ the memory places the data outputs after the access time of 65 ns
  - ▶ the data are transferred into internal registers of the CPU at the next clock pulse



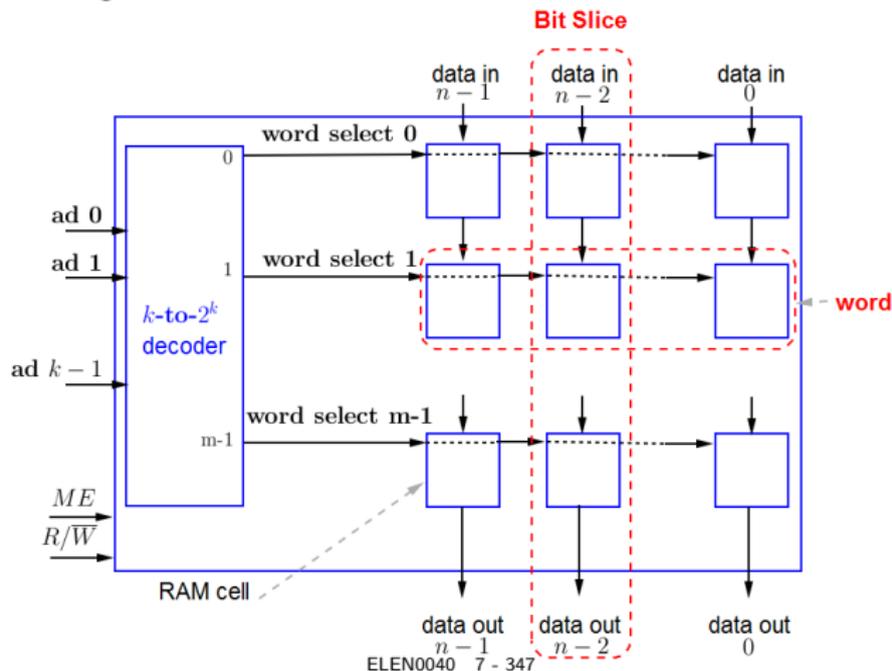
# Memory operation timing

- ▶ Example of **write timing**
  - ▶ the address is applied first with  $ME$  set to 1,  $R/\overline{W} = 1$
  - ▶ the address must be established at least a specified time before  $R/\overline{W}$  changes to 0 and held for at least a specified time before  $R/\overline{W}$  goes back to 1 to avoid disturbing stored contents of other addresses
  - ▶ data inputs must be established at least a specified time before and after  $R/\overline{W}$  goes back to 1 to write correctly
  - ▶  $ME$  remains at 1 during minimum the cycle time = the time required by the memory to complete its operations



# Static RAM realization

- ▶ A memory is made of an association of several RAM chips plus a control logic circuit.
- ▶ The internal structure of a RAM chip of  $m = 2^k$  words of  $n$  bits consists of an array of  $mn$  elementary storage cells + the required control logic circuit



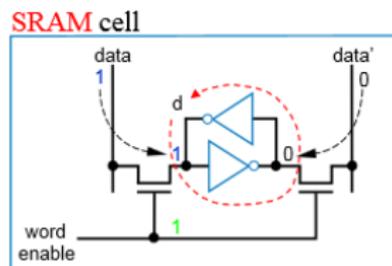
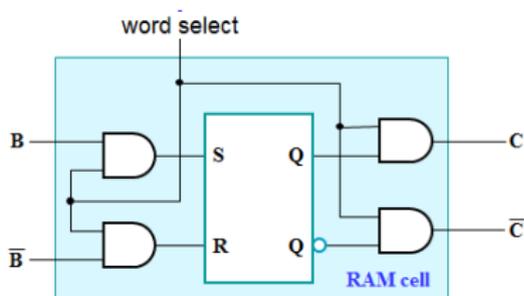
# Static RAM realization

We will consider successively :

- ▶ the constitution of an SRAM cell : the basic element to store one bit
- ▶ the association of  $m = 2^k$  RAM cells to build a bit slice memory of  $m$  words of one bit
- ▶ the association of  $n$  bit slices to build a memory chip of  $m$  words of  $n$  bits
- ▶ for larger memories, the association of several memory chips

# SRAM cell

- ▶ The basic storage cell is an electronic circuit using 6 transistors whose logic behavior may be modeled by an SR latch.



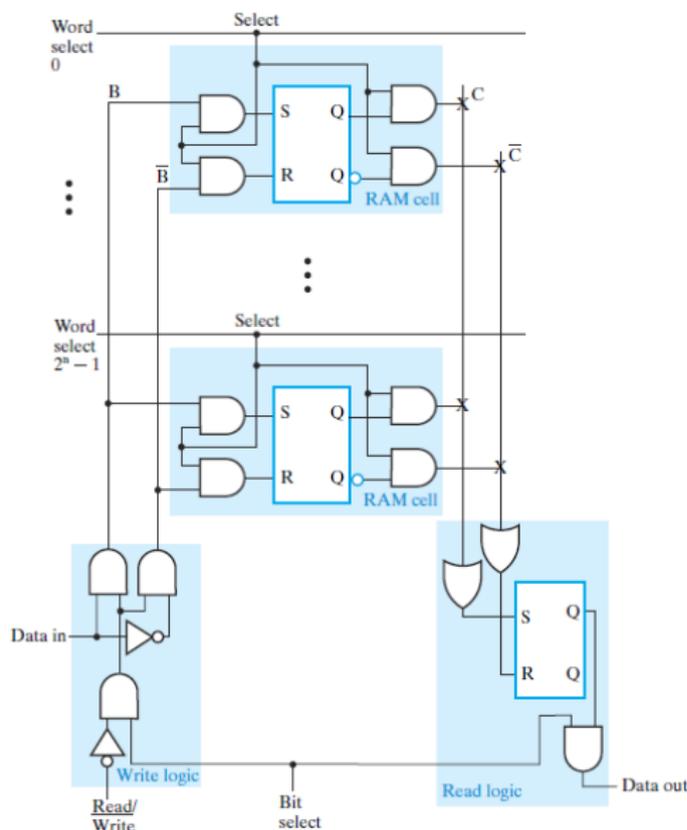
- ▶ Logic behavior :

word select=0     $C = \bar{C} = 0$      $Q$  holds stored value

word select=1     $C = B, \bar{C} = \bar{B}$

- ▶ Read and write operations are enabled by the “word select” input
- ▶  $B, \bar{B}$  are used for a write operation
- ▶  $C, \bar{C}$  are used for a read operation

# SRAM Bit Slice - Example



- ▶  $m$  RAM cells
- ▶ the write logic circuit derives  $B$  and  $\bar{B}$  inputs of the bit cells from the  $R/\bar{W}$  control and the Data In input
- ▶ the read logic circuit provides the Data Out output from the  $C$  and  $\bar{C}$  outputs of the bit cells and the  $R/\bar{W}$  control
- ▶ the memory enable signal is "Bit select"
- ▶ Write Logic :

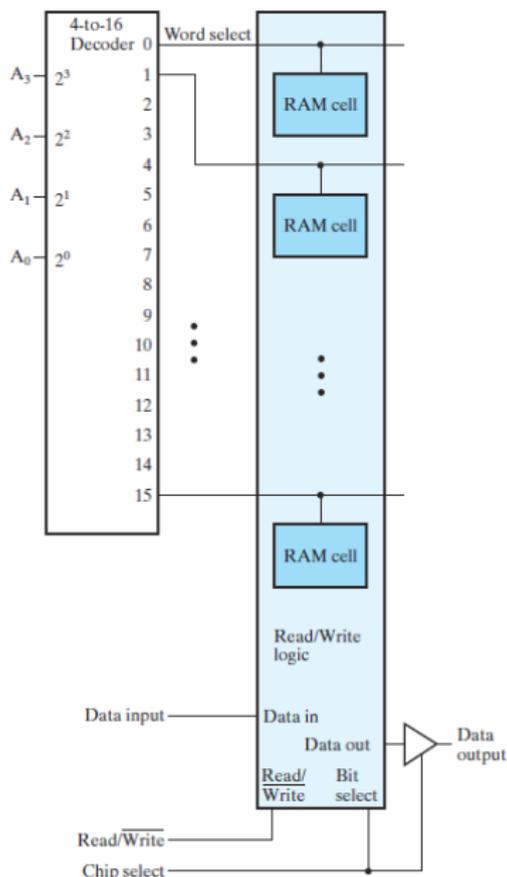
$$B = \text{BitSelect} \cdot \overline{R/\bar{W}} \cdot \text{DataIn}$$

$$\bar{B} = \text{BitSelect} \cdot \overline{R/\bar{W}} \cdot \overline{\text{DataIn}}$$

a new value is stored if the operation is enabled (BitSelect=1) and write operation is selected ( $R/\bar{W} = 0$ )

- ▶ If  $R/\bar{W} = 1$ ,  $B$  and  $\bar{B}$  of each cell are 0 and memorized values are kept unchanged

# $2^k \times 1$ SRAM Chip

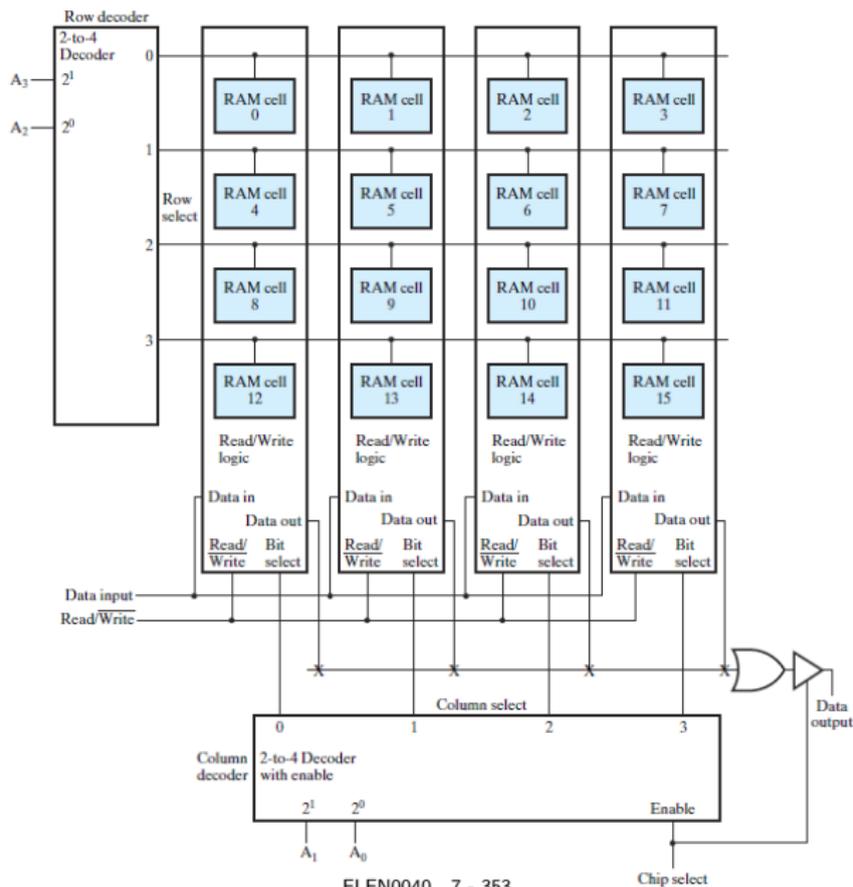


- ▶ To build a memory chip with 1-bit memory words, we need :
  - ▶ a decoder to decodes the  $k$  address lines to the  $2^k$  Word Select signals
  - ▶ a 3-state buffer at the output to be able to combine data outputs from different memory chips (one Chip Select at 1 at a time)
  - ▶ the memory enable signal is “Chip select”
- ▶ Example of  $16 \times 1$  SRAM Chip
- ▶ For words of 2 bits : connect
  - ▶ a second Bit Slice for the second data input
  - ▶ a 3-state buffer at the second data output
- ▶ ...

# Using an array of memory cells

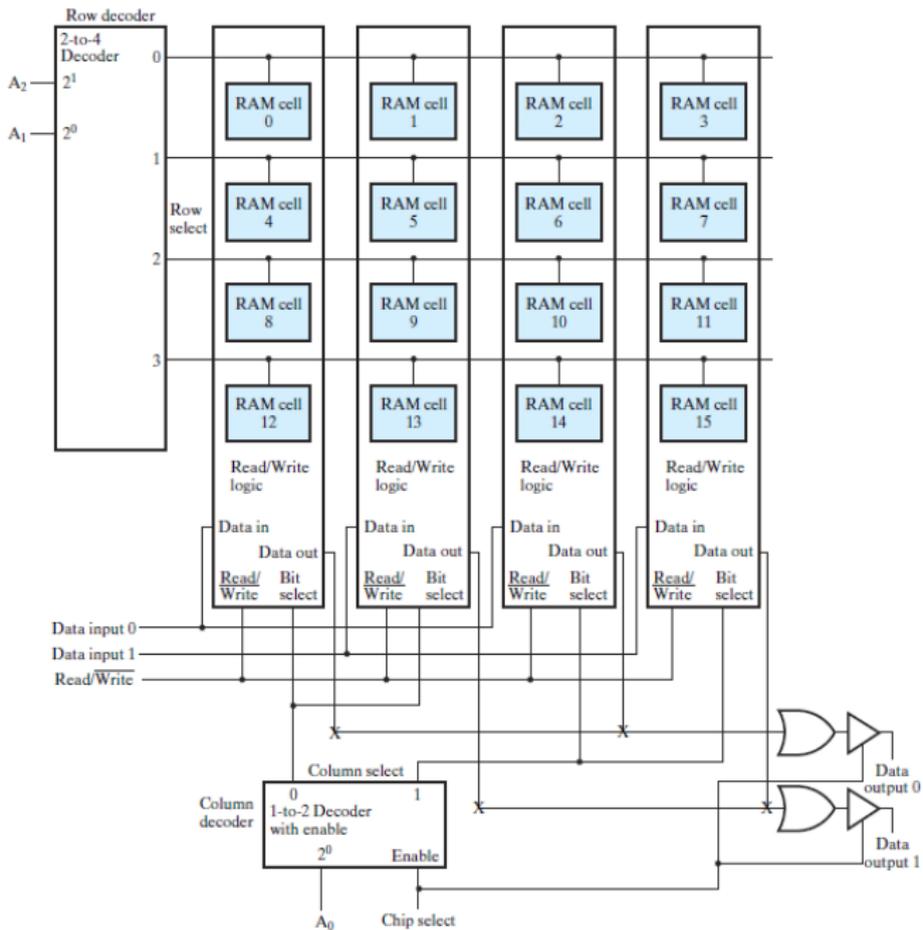
- ▶ Memory can have a large number of words
- ▶ The decoder size and the important fanouts of gates lead to an increase of the access and cycle times
- ▶ The use of a **two-dimensional array of cells** leads to better performances
- ▶ The cell selection uses two decoders of smaller size and several bit slices
- ▶ One cell is identified by its row and column
  - ▶ The address bits are split into two sets :
    - ▶ the half most significant bits are used to select the row
    - ▶ the half less significant bits are used to select the column, which corresponds to a bit slice
  - ▶ Word Select is replaced by **Row Select**
  - ▶ Bit Select is replaced by **Column Select**

# Example : $16 \times 1$ RAM



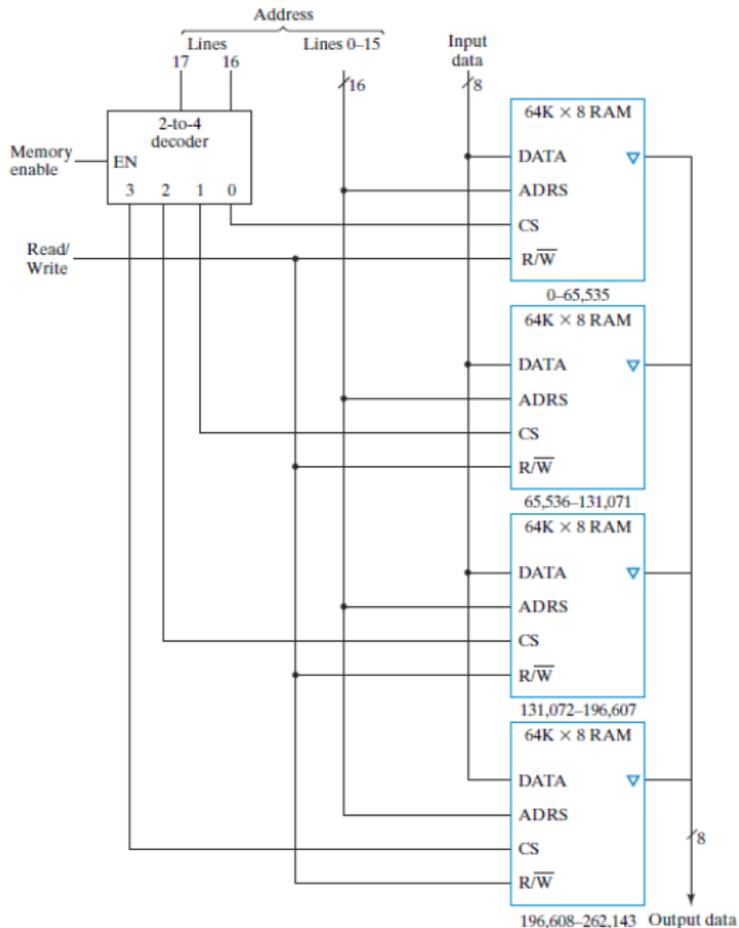
## RAM Chip with word length $> 1$ bit

- ▶ The same RAM cell array can be used to produce a  $8 \times 2$  RAM Chip
- ▶ 8 words  $\rightarrow$  3 address bits
- ▶ Row decoder : 2-to-4
- ▶ Column decoder : 1-to-2
- ▶ two Data In inputs, one for each bit of data
- ▶ each Column Select selects two columns, one for each Data In bit
- ▶ example : address 001 corresponds to cells 2,3
- ▶ two Data Out outputs



# Association of SRAM Chips

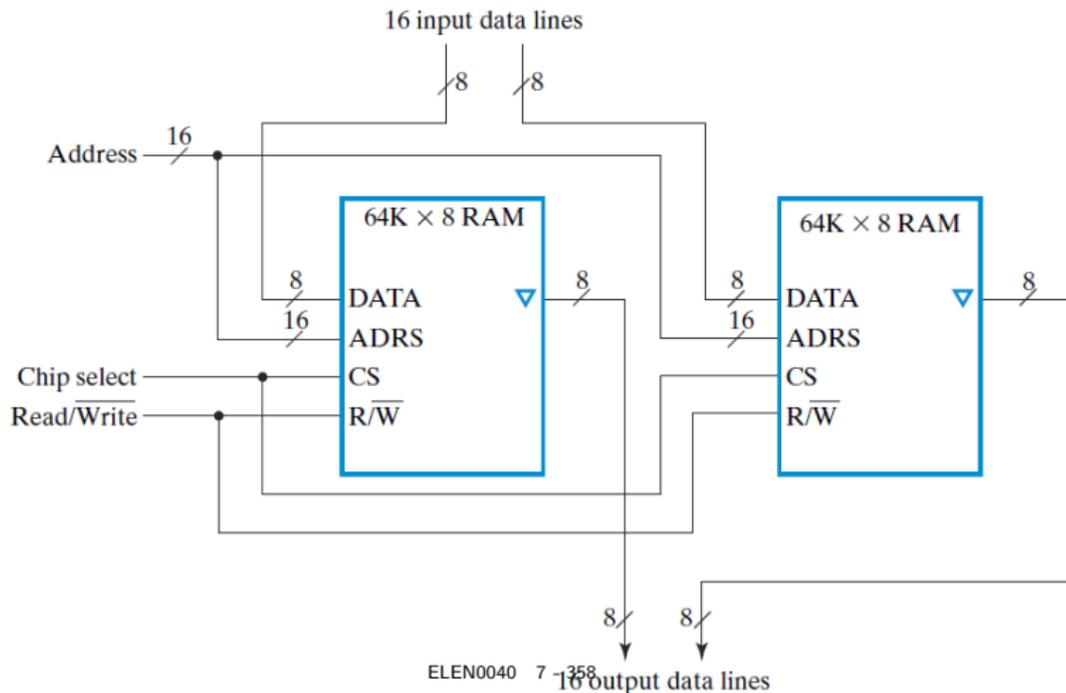
- ▶ Several RAM Chips are usually associated to :
  1. build memories of larger capacity, increase  $m$
  2. provide a larger word length, increase  $n$
- 1. Increase memory capacity
  - ▶ example : use four  $64K \times 8$  RAMs to provide  $256K \times 8$  RAM
  - ▶  $64K = 2^{16}$  : 16 address bits,  $256K = 2^{18}$ , 2 additional address bits are required
  - ▶ a 2-to-4 decoder is used to provide the 4 Chip Select signals to select one RAM chip, there is only one signal active at a time
  - ▶ the data input lines and the 16 least significant address lines are shared by the 4 Chips
  - ▶ the data output lines are connected together (Chip select on the enable input of the 3-state buffers present on each Chip output)



# Increase the word length

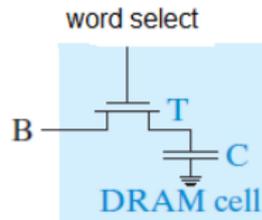
## 2. Combine two $64K \times 8$ RAMs to build a $64K \times 16$ RAM

- ▶ put the memory chips side-by-side
- ▶ the address and control lines are shared
- ▶ the two sets of 8 data input and output lines are concatenated to form the 16 output lines



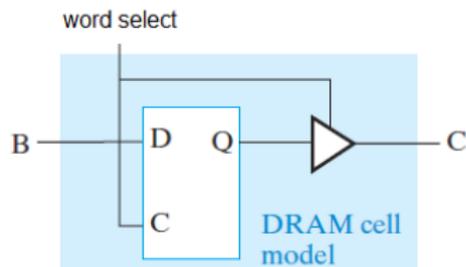
# Dynamic RAM - DRAM Cell

- ▶ The DRAM Cell is made of a transistor and an capacitor
- ▶ The capacitor is used to **store electrical charges**
  - ▶ high level of charges : logic value 1
  - ▶ low level of charges : logic value 0
- ▶ The transistor acts as a **switch** :
  - ▶ switch open : the value is stored
  - ▶ switch closed : a new value is transferred
- ▶ This cell needs to be refreshed periodically :
  - ▶ when the switch is open, there exists a **small leakage current**
  - ▶ the charge on the capacitor varies
  - ▶ the stored value will eventually be lost → **refresh operation is needed**
- ▶ During a read operation, the capacitor slightly charges or discharges and the amount of charges present on the capacitor at the end of the read operation does not correspond to 0 or 1 level, so that the stored value is destroyed = **destructive read**
- ▶ The original value has to be restored



## DRAM Cell - Logic model

- ▶ The logic cell behavior can be modeled by a D latch and a 3-state buffer



word select=0    C = High-Z    Q holds stored value  
word select=1    C = B

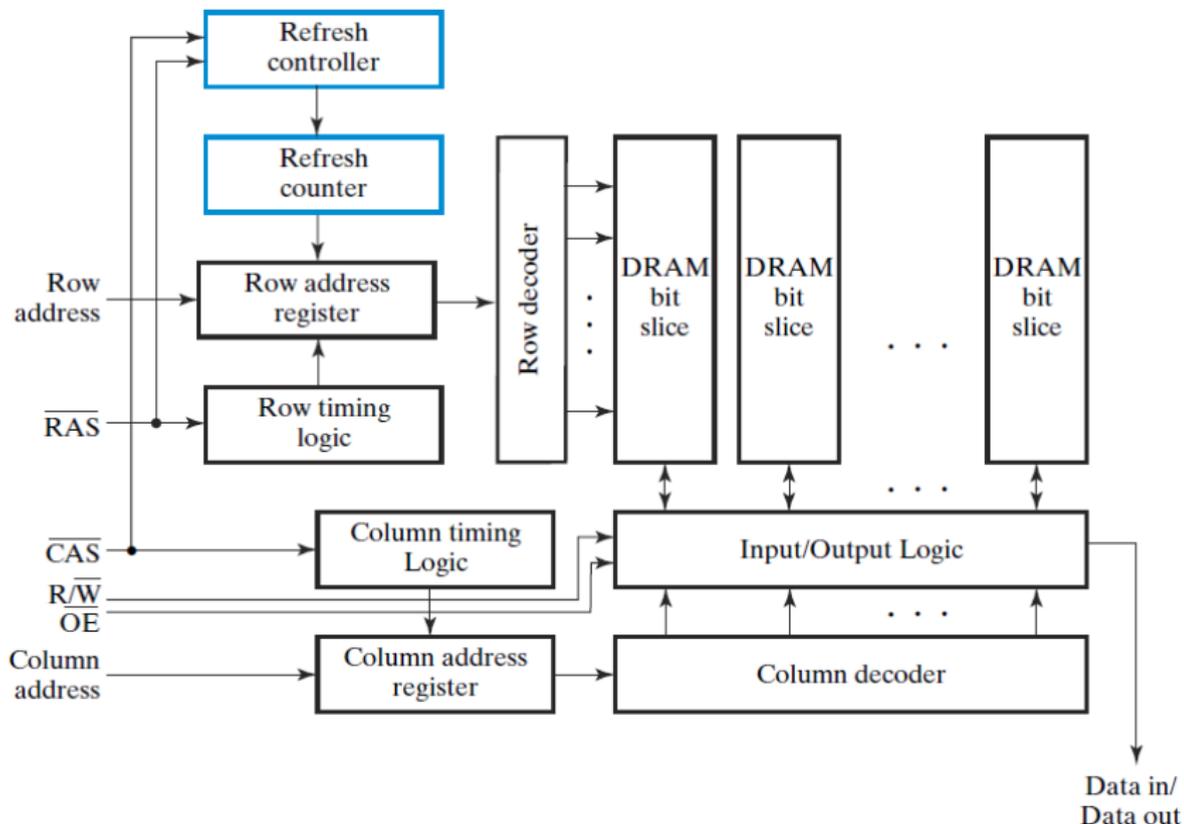
- ▶ Read and write operations are enabled by the “word select” input
- ▶ The DRAM Bit Slice model is similar to that of the SRAM bit but :
  - ▶ a sense amplifier is used to adapt the small voltage change on the capacitor to the high and low voltage levels
  - ▶ a 3-state buffer is used in the read logic circuit



# DRAM Chip

- ▶ As for SRAM, The design of a DRAM chip is made from an array of  $mn$  cells
- ▶ The DRAM cell is simpler than the SRAM cell and thus the number of DRAM cells on a chip can be higher ; DRAM chips are used to build large memories
- ▶ Hence, the number of address bits is high and to limit the complexity of the selecting circuit, the row and column addresses are applied serially
- ▶ A row and a column register are added to store the address during the operations
- ▶ The control timing signals are :
  - ▶  $\overline{RAS}$  to control the loading of the row address into the row-register, the row address is loaded first
  - ▶  $\overline{CAS}$  to control the loading of the column address into the column-register
  - ▶  $R/\overline{W}$  to select between read and write operation
  - ▶  $\overline{OE}$  enables the output on Data output lines in a read operation
- ▶ The refresh logic includes a refresh controller and a refresh counter

# DRAM Block Diagram



# Association of DRAM Chips

- ▶ Similar procedures as for SDRAM : build larger memories with increased capacity and word length
- ▶ Addition of a **DRAM Controller** to :
  - ▶ separate the address into row address and column address and define the timing of their application
  - ▶ perform the periodic refresh operation
  - ▶ provide status signals to the rest of the system, indicating e.g. whether or not the memory is available or busy performing refresh,...

# DRAM types

Technology improvements enable to increase capacity and speed at the price of more sophisticated control. Actually, three main types of performing DRAM :

- ▶ **Synchronous DRAM** :
  - ▶ transfers to and from the DRAM are synchronized with the system clock
  - ▶ take advantage of the row/column address separation : contiguous words can be read using the same row address
- ▶ **DDR DRAM** : Double Data Rate synchronous DRAM, a synchronous DRAM where
  - ▶ transfers of data occur on both edges of the clock cycle
  - ▶ the transfer rate is thus doubled : 2 data words per clock cycle
- ▶ **Rambus DRAM** :
  - ▶ use a dedicated bus allowing transmission of packed data between memory and the memory bus to the processor

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## ② Random Access Memory (RAM)

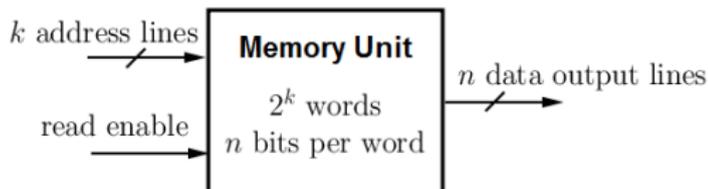
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# Read Only Memory

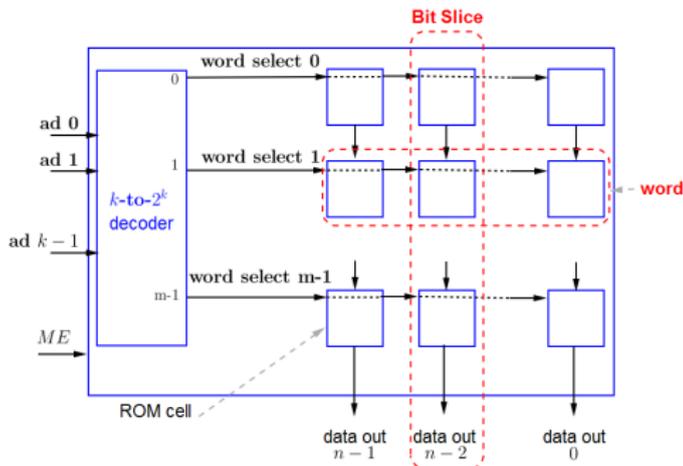
- ▶ Memory that can only be read from, not written to
  - ▶  $k$  address lines
  - ▶ **no data input** lines
  - ▶  $n$  output data lines
  - ▶ one possible control signal to enable the read operation, no  $R/\overline{W}$  control input



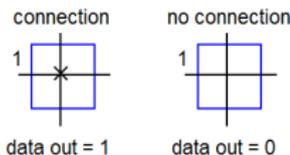
- ▶ Advantages over RAM :
  - ▶ compact : may be smaller
  - ▶ nonvolatile : save bits even when power supply is off
  - ▶ speed : may be faster (especially than DRAM)
  - ▶ used to store data or programs that won't change

# ROM - internal structure

- ▶ The internal logical structure is similar to RAM, without the data input lines



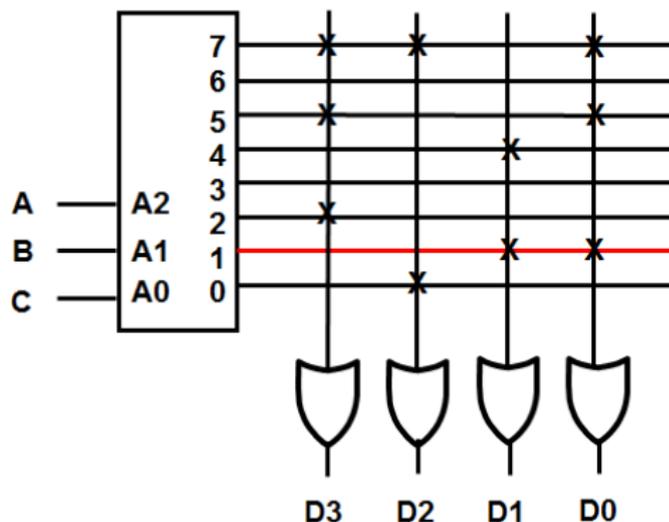
- ▶ The memory cell uses one transistor acting as a connector that can be programmed to model 0 or 1 logic value. This can be symbolically represented as follows :



# ROM - Example

- ▶ a  $8 \times 4$  ROM
- ▶ 3 address lines
- ▶ 4 data output lines
- ▶ Stored values

address	data
000	0100
001	0011
010	1000
011	0000
100	0010
101	1001
110	0000
111	1101

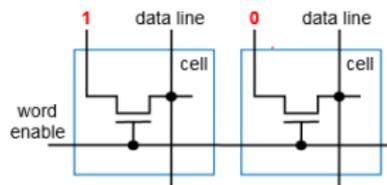


# ROM types

Several types depending on the way the stored values are “programmed”

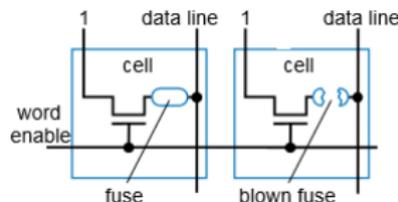
## ▶ ROM or mask-programmed ROM

- ▶ bits are hardwired as 0s or 1s during chip manufacturing
- ▶ word enable (from decoder) simply passes the hardwired value through the transistor
- ▶ very fast and compact memory



## ▶ PROM or Fused-Based Programmable ROM

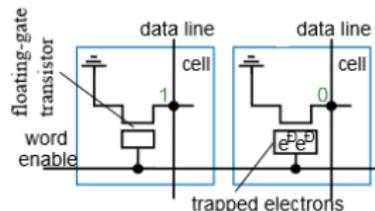
- ▶ each cell has a fuse
- ▶ a special device, a “programmer”,
  - ▶ blows fuses to code a 0 value
  - ▶ leaves fuse intact to code a 1 value
- ▶ the memory can be programmed only once



# ROM types (continued)

## ▶ EPROM or Erasable Programmable ROM

- ▶ use a “floating-gate transistor”
- ▶ a “programmer” device uses higher than normal voltage to “trap” electrons into the gate for cells that should store 0
- ▶ for other cells, stored value will be 1
- ▶ stored data can be erased by exposing the chip to a shine ultraviolet light
- ▶ the whole memory is erased



## ▶ EEPROM or Electronically - Erasable Programmable ROM

- ▶ similar to EPROM but erasing is done **electronically**
- ▶ the erasing is done one word at a time
- ▶ more bulky than EPROM

# ROM types (continued)

- ▶ Flash Memory
  - ▶ Similar to EEPROM, but all words or large blocks of words can be erased simultaneously
  - ▶ Higher density of integration than EEPROM
  - ▶ Both types, when embedded in systems
    - ▶ can be reprogrammed to store new values
    - ▶ require bidirectional data lines and read/write control input
    - ▶ also need a busy status output to indicate that erasing is in progress
- ▶ We define that
  - ▶ RAM is readable and writable
  - ▶ ROM is read-only
- ▶ But some ROMs act almost like RAMs
  - ▶ EEPROM and Flash are in-system programmable but
  - ▶ write operation is slower than in RAMs
  - ▶ the number of writes may be limited
- ▶ Some RAMs act almost like ROMs
  - ▶ Nonvolatile RAMs have also been devised

# Références

- ▶ *Logic and Computer Design Fundamentals, 4/E*, M. Morris Mano Charles Kime , Course material  
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- ▶ *Lecture notes, Course CSE370 - Introduction to Digital Design*, Spring 2006, University of Washington,  
<https://courses.cs.washington.edu/courses/cse370/06sp/pdfs/>
- ▶ *Lecture notes, Course ECE274 - Digital Logic*, Spring 2009, University of Arizona,  
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